

MAXIMUM RATINGS

Rating	Symbol	Value		Unit
Collector-Emitter Voltage	V_{CE0}	40		Vdc
Collector-Base Voltage	V_{CBO}	50		Vdc
Emitter-Base Voltage	V_{EBO}	5.0		Vdc
Collector Current — Continuous	I_C	50		mAdc
		One Die	All Die Equal Power	
Total Device Dissipation @ $T_A = 25^\circ\text{C}$ MD3250,A, MD3251,A MD3250F,AF, MD3251F,AF MQ3251	P_D	575	625	mW
		350	400	
		400	600	
Derate above 25°C MD3250,A, MD3251,A MD3250F,AF, MD3251F,AF MQ3251	P_D	3.29	3.57	mW/ $^\circ\text{C}$
		2.0	2.28	
		2.28	3.42	
Total Device Dissipation @ $T_C = 25^\circ\text{C}$ MD3250,A, MD3251,A MD3250F,AF, MD3251F,AF MQ3251	P_D	1.8	2.5	Watts
		1.0	2.0	
		0.9	3.6	
Derate above 25°C MD3250,A, MD3251,A MD3250F,AF, MD3251F,AF MQ3251	P_D	10.3	14.3	mW/ $^\circ\text{C}$
		5.71	11.4	
		5.13	20.5	
Operating and Storage Junction Temperature Range	T_J, T_{stg}	-65 to +200		$^\circ\text{C}$

MD3250,A,F,AF
MD3251,A,F,AF
MQ3251

MD3250,A
MD3251,A
CASE 654-07, STYLE 1

MD3250F,AF
MD3251F,AF
CASE 610A-04, STYLE 1

MQ3251
CASE 607-04, STYLE 1

DUAL
AMPLIFIER TRANSISTOR

PNP SILICON

THERMAL CHARACTERISTICS

Characteristic	Symbol	One Die	All Die Equal Power	Unit
Thermal Resistance, Junction to Case MD3251,A, MD3251,A MD3250F,AF, MD3251F,AF MQ3251	$R_{\theta JC}$	97 175 195	70 87.5 48.8	$^{\circ}\text{C/W}$
Thermal Resistance, Junction to Ambient MD3250,A, MD3251,A MD3250F,AF, MD3251F,AF MQ3251	$R_{\theta JA}(1)$	304 500 438	280 438 292	$^{\circ}\text{C/W}$
		Junction to Ambient	Junction to Case	
Coupling Factors MD3250,A, MD3251,A MD3250F,AF, MD3251F,AF MQ3251 (Q1-Q2) (Q1-Q3 or Q1-Q4)		84 75 57 55	44 0 0 0	%

(1) $R_{\theta JA}$ is measured with the device soldered into a typical printed circuit board.

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS					
Collector-Emitter Breakdown Voltage(2) ($I_C = 10\text{ mAdc}$, $I_E = 0$)	$V_{(BR)CEO}$	40	—	—	Vdc
Collector-Base Breakdown Voltage ($I_C = 10\text{ }\mu\text{Adc}$, $I_E = 0$)	$V_{(BR)CBO}$	50	—	—	Vdc
Emitter-Base Breakdown Voltage ($I_E = 10\text{ }\mu\text{Adc}$, $I_C = 0$)	$V_{(BR)EBO}$	5.0	—	—	Vdc
Collector Cutoff Current ($V_{CB} = 40\text{ Vdc}$, $I_E = 0$) ($V_{CB} = 40\text{ Vdc}$, $I_E = 0$, $T_A = 150^\circ\text{C}$)	I_{CBO}	—	—	10	nAdc
Emitter Cutoff Current ($V_{BE} = 3.0\text{ Vdc}$, $I_C = 0$)	I_{EBO}	—	—	10	nAdc

MD3250,A,F,AF, MD3251,A,F,AF, MQ3251

ELECTRICAL CHARACTERISTICS (continued) ($T_A = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit	
ON CHARACTERISTICS(2)						
DC Current Gain ($I_C = 10\ \mu\text{Adc}$, $V_{CE} = 5.0\ \text{Vdc}$) ($I_C = 100\ \mu\text{Adc}$, $V_{CE} = 5.0\ \text{Vdc}$) ($I_C = 100\ \mu\text{Adc}$, $V_{CE} = 5.0\ \text{Vdc}$, $T_A = -55^\circ\text{C}$) ($I_C = 1.0\ \text{mA dc}$, $V_{CE} = 5.0\ \text{Vdc}$) ($I_C = 10\ \text{mA dc}$, $V_{CE} = 5.0\ \text{Vdc}$) ($I_C = 50\ \text{mA dc}$, $V_{CE} = 5.0\ \text{Vdc}$)	MD3250,A,F,AF MD3251,A,F,AF MD3250,A,F,AF MD3251,A,F,AF MQ3251 MD3250,A,F,AF MD3251,A,F,AF MQ3251 MD3250,A,F,AF MD3251,A,F,AF MQ3251 MD3250,A,F,AF MD3251,A,F,AF MQ3251	h_{FE}	25 50 50 80 80 25 50 50 100 100 50 100 100 15 30 30	75 100 82 170 170 35 75 87 180 180 92 190 190 50 90 90	— — 150 300 — — — 150 300 — — — 300 — — —	—
Collector-Emitter Saturation Voltage ($I_C = 10\ \text{mA dc}$, $I_B = 1.0\ \text{mA dc}$) ($I_C = 50\ \text{mA dc}$, $I_B = 5.0\ \text{mA dc}$)		$V_{CE(sat)}$	— —	0.11 0.18	0.25 0.5	Vdc
Base-Emitter Saturation Voltage ($I_C = 10\ \text{mA dc}$, $I_B = 1.0\ \text{mA dc}$) ($I_C = 50\ \text{mA dc}$, $I_B = 5.0\ \text{mA dc}$)		$V_{BE(sat)}$	0.6 —	0.78 0.88	0.9 1.2	Vdc
SMALL-SIGNAL CHARACTERISTICS						
Current-Gain — Bandwidth Product ($I_C = 10\ \text{mA dc}$, $V_{CE} = 20\ \text{Vdc}$, $f = 100\ \text{MHz}$)	MD3250,A,F,AF MD3251,A,F,AF MQ3251	f_T	200 250 300	600 600 600	— — —	MHz
Output Capacitance ($V_{CB} = 5.0\ \text{Vdc}$, $I_E = 0$, $f = 100\ \text{kHz}$)		C_{obo}	—	2.5	6.0	pF
Input Capacitance ($V_{BE} = 1.0\ \text{Vdc}$, $I_C = 0$, $f = 100\ \text{kHz}$)		C_{ibo}	—	6.0	8.0	pF
MATCHING CHARACTERISTICS (MD3250,A,F,AF & MD3251,A,F,AF ONLY)						
DC Current Gain Ratio(3) ($I_C = 100\ \mu\text{Adc}$, $V_{CE} = 5.0\ \text{Vdc}$) ($I_C = 1.0\ \text{mA dc}$, $V_{CE} = 5.0\ \text{Vdc}$)		h_{FE1}/h_{FE2}	0.9 0.9	— —	1.0 1.0	—
Base-Emitter Voltage Differential ($I_C = 100\ \mu\text{Adc}$, $V_{CE} = 5.0\ \text{Vdc}$) ($I_C = 10\ \mu\text{Adc}$, $V_{CE} = 5.0\ \text{Vdc}$) ($I_C = 10\ \text{mA dc}$, $V_{CE} = 5.0\ \text{Vdc}$)		$ V_{BE1}-V_{BE2} $	— — —	— — —	3.0 5.0 5.0	mVdc
Base-Emitter Voltage Differential Change Due to Temperature ($I_C = 100\ \mu\text{Adc}$, $V_{CE} = 5.0\ \text{Vdc}$, $T_A = -55\ \text{to} +25^\circ\text{C}$) ($I_C = 100\ \mu\text{Adc}$, $V_{CE} = 5.0\ \text{Vdc}$, $T_A = +25\ \text{to} +125^\circ\text{C}$)		$\Delta V_{BE1}/V_{BE2} $	— —	— —	0.8 1.0	mVdc

(2) Pulse Test: Pulse Width $\leq 300\ \mu\text{s}$, Duty Cycle $\leq 2.0\%$.

(3) The lowest h_{FE} reading is taken as h_{FE1} for this ratio.

MD3250,A,F,AF, MD3251,A,F,AF, MQ3251

FIGURE 1 – CAPACITANCE

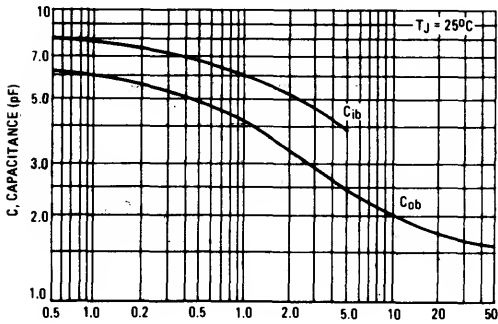
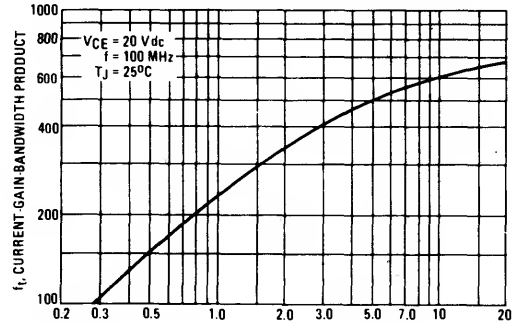


FIGURE 2 – CURRENT-GAIN BANDWIDTH PRODUCT



NOISE FIGURE VARIATIONS

($V_{CE} = 6.0\text{ V}$, $T_A = 25^\circ\text{C}$)

FIGURE 3 – EFFECTS OF FREQUENCY

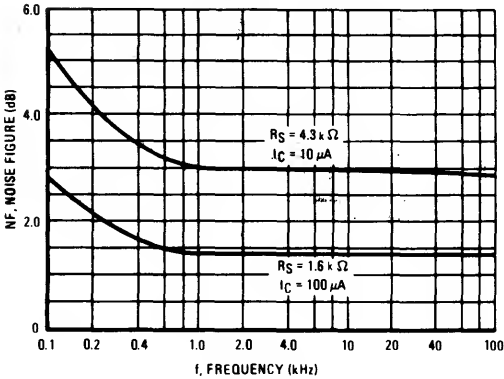


FIGURE 4 – EFFECTS OF SOURCE RESISTANCE

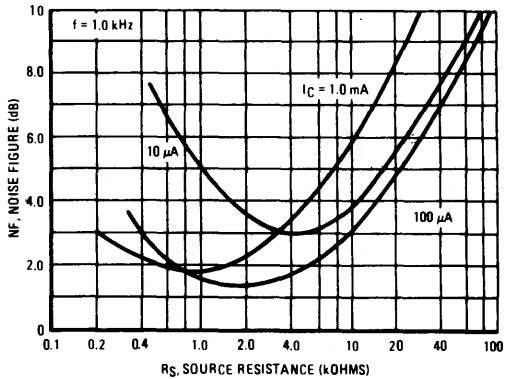
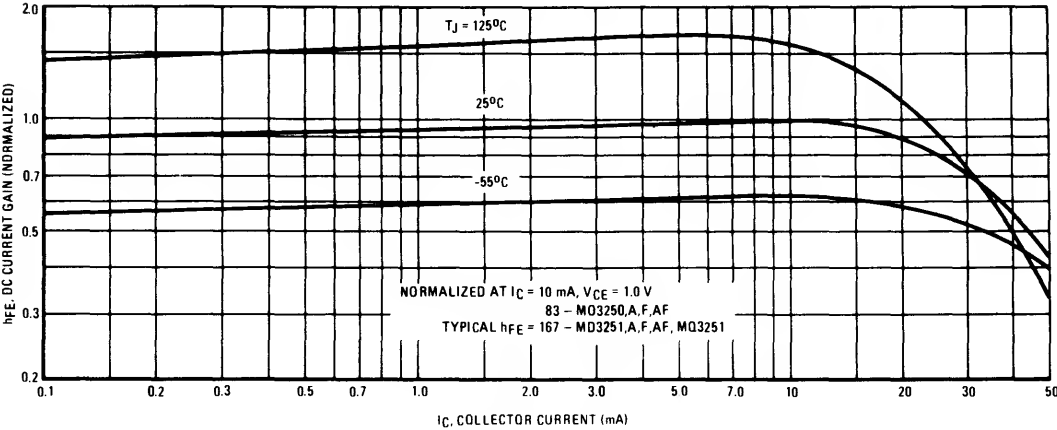


FIGURE 5 – DC CURRENT GAIN



MD3250,A,F,AF, MD3251,A,F,AF, MQ3251

FIGURE 6 — "ON" VOLTAGE

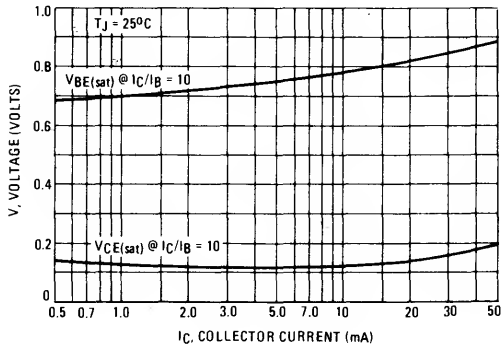
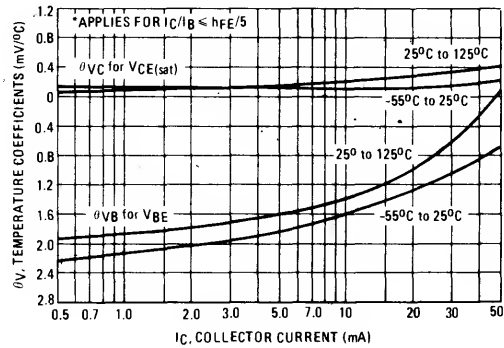


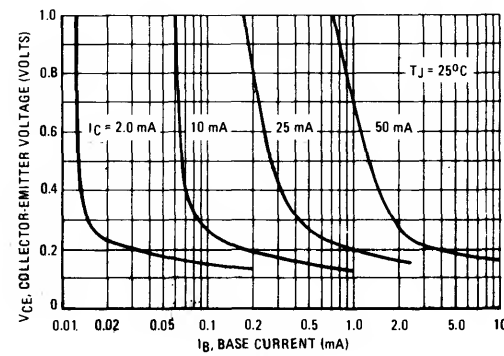
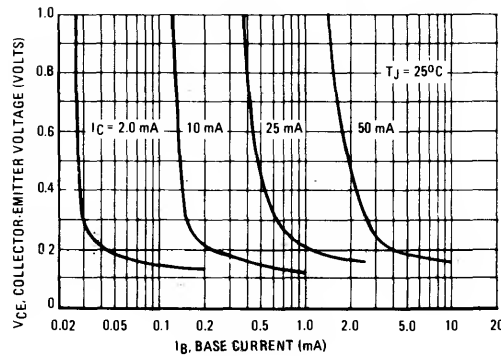
FIGURE 7 — TEMPERATURE COEFFICIENTS



MD3250

FIGURE 8 — COLLECTOR SATURATION REGION

MD3251, MQ3251



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